

<b>Notice of References Cited</b>	Application/Control No. 09/987,520	Applicant(s)/Patent Under Reexamination KOIKE, TAKAHISA	
	Examiner Sophia S. Chen	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0016972 A1	02-2002	Ogawa et al.	725/133
	B	US-2002/0054324 A1	05-2002	Okada et al.	358/1.15
	C	US-2002/0057451 A1	05-2002	Ishijima, Hiroyasu	358/1.15
	D	US-2002/0063885 A1	05-2002	Dutta, Rabindranath	358/1.15
	E	US-6,404,994 b1	06-2002	Kawai et al.	399/6
	F	US-2002/0080384 A1	06-2002	Hobbs, George Bradley	358/1.15
	G	US-6,705,781 B2	03-2004	Iwazaki, Ryuji	358/1.15(X)
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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